S/N 09/834,751

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Sergey A. Velichko et al.

Examiner: Manuel L. Barbee

Serial No.:

09/834,751

Group Art Unit: 2857

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Title:

CONCURRENT CONTROL OF SEMICONDUCTOR PARAMETRIC

TESTING

AMENDMENT AND RESPONSE UNDER 37 CFR § 1.111

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

This responds to the Office Action mailed on May 25, 2007. Please amend the above-identified patent application as follows.